

Thin Films and Surface Modification

Room Naupaka Salon 4 - Session TF1-MoE

Thin Films - Materials I

Moderator: Ryo Toyoshima, The University of Tokyo

5:40pm **TF1-MoE-1 Plasma Diagnostic-Based Plasma Processing for Semiconductor and Nanomaterial Manufacturing**, *Hyo-Chang Lee*, Korea Aerospace University, Republic of Korea

INVITED

Plasma has been actively used in semiconductor and nanomaterial manufacturing. As the structures of nanostructures and semiconductor devices become more complex, plasma process technology based on plasma characteristic measurement is needed. In this invited talk, several key plasma process results, including analysis of the correlations between process results and plasma variables, are presented.

6:20pm **TF1-MoE-3 Tailoring High Temperature Anti-Oxidizing Coatings by Sol-Gel Chemistry for Enhanced Aeronautic Efficiency**, *L. Lager*, University Lyon 1, France; *S. Senani-De Monredon*, *J. Delfosse*, Safran Tech, France; *S. Benayoun*, Ecole Centrale de Lyon, France; *Berangere Toury*, University Lyon 1, France

Reducing polluting gases emissions is a major strategic challenge for the aeronautic industry. Two approaches exist to achieve this : increasing engine operating temperatures and/or reducing the total mass of the aircraft. Titanium alloys, due to their low density, good damage tolerance, and excellent fatigue resistance, are particularly attractive for use up to temperatures of 500°C.

To date, the scientific challenge concerning these alloys is to extend their operating temperature resistance up to 600-700°C while maintaining or improving their specific properties required for the aimed application. One of the main causes of degradation in these alloys when used at high temperatures is related to oxidation. Actually, for these materials, oxidation can occur in two distinct ways : firstly, the formation of an external oxide layer (TiO₂), and secondly, significant oxygen diffusion within the underlying alloy. This second phenomenon is linked to the high solubility of oxygen in titanium. In both cases, without additional protection, the use of titanium alloys at high temperatures considerably reduces their mechanical properties, especially ductility.

In this context, the main goal of this study is focused on the design, synthesis and characterization of a high temperatures anti-oxidizing coating based on rare earth aluminate for enhanced titanium alloys used in aeronautics. In this work, we are interested in the synthesis of protective coatings by using the sol gel process, which is a versatile method allowing direct enduction of the sol on metallic substrates. Thus, leveraging precise control over sol chemistry enables the reach of coatings with desired stoichiometry. The morphology of the coatings is meticulously examined via SEM. Additional characterizations utilizing XPS, solid NMR, and thermal analyses were used to understand curing mechanisms. Initial oxidation tests reveal promising prospects for the application of these coatings in aeronautic contexts, potentially enhancing engine efficiency while mitigating environmental impact.

6:40pm **TF1-MoE-4 Fabrication and Characterizations of Aluminum Doped Cadmium Oxide (CdO:Al) Thin Film Using Sol-Gel Spin-Coating Method**, *Moniruzzaman Syed*, *J. Massey*, *M. Hurd*, LeMoyne Owen College; *M. syeda*, University of Memphis

Aluminum-doped cadmium oxide (CdO:Al) thin films are deposited on silica substrates by the sol-gel spin-coating method as a function of spin coater's rpm (revolution per minute). Cadmium acetate dihydrate and Aluminum nitrate have been taken as the precursor material and a source of Al-dopant respectively. CdO:Al thin films are characterized by x-ray diffraction (XRD), Fourier Transform Infrared (FT/IR), Field emission scanning electron microscopy (FE-SEM) and SEM-EDX. XRD result indicates the highest crystallinity at 6000 rpm with a crystallite size of 31.845 nm, cubic phase formation, and strain of $\sim 1.6 \times 10^{-2}$. FE-SEM/SEM/EDX shows the well-faceted homogeneous surface structure at 6000 rpm having an average particle size of 130.05 nm. FT/IR confirms the presence of CdO:Al in the film with the peak position shifting to higher wavenumbers.

7:00pm **TF1-MoE-5 Structural and Electronic Impact on Various Substrates of Tio2 Thin Film Using Sol-Gel Spin Coating Method**, *Afrika Leiwis*, *T. Crosby*, *J. Muhammad*, LeMoyne Owen College; *M. Syeda*, University of Memphis; *M. Syed*, LeMoyne Owen College

Titanium dioxide (TiO₂) thin films have been deposited on Corning 7059 glass and Fused quartz silicate substrates using the Sol-Gel spinning coating technique. On glass substrates, there are four Raman active bands are observed: 3Anatase [A<149cm⁻¹>, A<523cm⁻¹> and A<646cm⁻¹>] and 1 Rutile B<401 cm⁻¹>. On silica substrates, additional two more bands which are R<859 cm⁻¹> and B<1068 cm⁻¹> detected. The deposited films show polycrystalline nature with high XRD intensity peaks in (110), (200) and (211) orientation corresponding to anatase and rutile phases respectively with tetragonal BCC structure. The other orientations (101), (111), (210), (211), (220), (201), (002), (204) and (116) are also observed for all films with low intensities. XRD crystal sizes are found to increase with increasing annealing temperature on both substrates. Maximum crystal sizes are found to be ~ 31 nm on silica substrates and ~ 23 nm on glass substrates at 500°C. On glass substrate, TiO₂ thin film shows the agglomeration of various non-uniform flaky type of structures. On silica substrate, the FESEM micrographs show the following observations: (i) particles are spherical in shape with forming different islands (ii) particles are soft agglomerates/spongy in nature with uniform surface, (iii) each spherical agglomerate contains many particles in the nanometric range and (iv) the agglomerate size is in between 40 and 110 nm. FE-SEM TiO₂ particles size distribution at 500°C showed that the average particle size is 89.55 and 110.35 nm on glass and silica substrates respectively.

Thin Films and Surface Modification

Room Naupaka Salon 4 - Session TF2-MoE

Thin Films - Characterization

Moderator: Chen-Hao Wang, National Taiwan University of Science and Technology

7:40pm **TF2-MoE-7 In-Situ/Operando Soft X-Ray Measurements for Hydrogen Related Surface Functional Materials**, *Ryo Toyoshima*, The University of Tokyo, Japan

INVITED

Chemical reactions at surfaces have been widely used for chemical processes such as catalytic synthesis, energy conversion, environmental cleanup, and sensor. Surface science techniques enable us to understand physicochemical fundamental processes on surfaces. However, one drawback of such surface science techniques is that the experiments are carried out under vacuum in many cases. We have developed some in situ / operando experimental techniques for observing surface reactions on liquid/solid and gas/solid interfaces in energy range from infrared to soft X-ray. We have focused on the development and understanding of heterogeneous catalysts using hydrogen gas as a reducing agent [1], and sensing materials to detect small molecules such as hydrogen [2], by ambient pressure X-ray photoelectron spectroscopy (AP-XPS). The experiments were carried out at a beamline BL-13 at the Photon-Factory of High Energy Accelerator Research Organization (KEK-PF). The AP-XPS system is consisted of a high-pressure chamber, preparation chamber and load-lock chamber. An important technical point of the AP-XPS system is that the high-pressure chamber, where quasi-atmospheric gases are introduced, and the electron analyzer are separated by a small aperture and pumped by a differential pumping system. It keeps the pressure of electron analyzer under ultra-high vacuum, and it also reduces the scattering of photoelectrons in the gas atmosphere. Recently, a sensor material has been developed that can detect H₂ gas in air and breath with high sensitivity (1 ppm) using nanometer-thick platinum-based thin films [2]. Figure 1 shows a result of operando AP-XPS measurement for H₂ sensing Pt-Rh thin-film sensor. The Pt-Rh sensor detects the atmospheric concentration of H₂ gas by changing in electric resistivity. Here, a 10 nm-thick Pt-Rh thin-film deposited on a SiO₂ substrate was used for the measurements. Figure 1(a) shows time evolution of relative electric resistivity ($\Delta R/R$). The resistivity decreases with exposing H₂ gas to the sensor surface, whereas it increases with exposing O₂ gas. Figure 1(b) shows corresponding Rh 3d and Pt 4f XPS. Before the gas dosing (i), the surface was dominated by Rh oxide. When the surface was exposed to the H₂ gas, the chemical state clearly changed. The Rh oxide was completely reduced to the metallic state. When the surface was exposed to the O₂ gas, the oxygen-induced species grew up again. Those findings indicate the surface chemical state strongly relates to the material functions.

[1] Toyoshima, R. et al. J. Phys. Chem. C 2021, 125, 4540–4549.

Monday Evening, December 9, 2024

[2] Toyoshima, R. et al. J. Phys. Chem. Lett. 2022, 13, 8546–8552.

8:20pm **TF2-MoE-9 NAP HAXPES from Tender X-Ray Energies**, *Paul Dietrich*, SPECS Surface Nano Analysis GmbH, Germany

X-ray photoelectron spectroscopy (XPS) is a powerful technique for investigating a wide range of materials' chemical composition and electronic structure. The information depth of XPS is contingent upon the inelastic mean free path (IMFP) of the photoelectrons in solid matter. The IMFP as a function of kinetic energy exhibits a pronounced minimum at kinetic electron energies between 40 and 100 eV. The maximum kinetic energy of photoelectrons in an XPS experiment depends on photon energy. In this context, typical photon energies employed in laboratory settings and at synchrotron radiation facilities range up to 1500 eV. In such experiments, the inelastic mean free path is typically around a few nanometers making conventional XPS a surface-sensitive technique. It is necessary to increase the kinetic energy of electrons by using higher photon energies for excitation to gain access to properties at the bulk and interface levels. In hard X-ray photoelectron spectroscopy (HAXPES), photon energies typically range between 3 keV and 15 keV, thereby extending the information depth to 10–30 nm.

The μ FOCUS 450 is a versatile small-spot multi-wavelength X-ray monochromator for surface analysis and depth profiling applications. This fully computer-controlled device allows for in situ switching between different emitters for Al, Ag, and Cr excitation, thus providing X-rays with high flux density for various applications such as small, medium, and high energy XPS. This new monochromator is an all-in-one solution for (NAP) XPS and (NAP) HAXPES systems. It combines the high performance of the standard aluminum K α excitation (1487 eV) with silver L α and chromium K α excitation lines at 2984 eV and 5414 eV, respectively. The new design hosts up to three anodes and the corresponding monochromator optics in one Rowland circle based housing.

Due to signal absorption in the surrounding gas, NAP XPS is one of the most challenging applications in surface analysis. High-performance analyzers, such as the AEOLOS 150 NAP, require a matched X-ray source, fitting the small analyzer field of view and the need for a high flux density on the smallest spots. The μ FOCUS 450 is designed to cover these requirements for highly efficient NAP XPS and NAP HAXPES measurements. The combination of our monochromatic three-color X-ray source μ FOCUS 450 with Al, Ag, and Cr anodes together with the high transmission hemispherical analyzer AEOLOS 150 NAP is ideally suited for studies of interfaces under reactive conditions extending the information depth from the surface into the bulk. We will present a selection of recent (NAP) HAXPES results from different types of samples.

8:40pm **TF2-MoE-10 Redox XPS; Progressive *proxime situ* Oxidation in XPS (and SIMS) as an Aid to Spectrum Interpretation**, *Peter Cumpson*, La Trobe University, Australia; *D. Devadasan*, Thermo Fisher Scientific, UK; *S. Gazzola*, University of Bath, U.K.; *T. Nunney*, Thermo Fisher Scientific, UK; *R. Weatherup*, Oxford University, UK

We have developed a method of exposing surface analysis samples to a progressive series of oxidation steps in the entry-lock of a UHV instrument (e.g. ThermoFisher K-Alpha and NEXSA XPS instruments). Shortwave UV and part-per-million ozone are used in automated steps to progressively oxidise specimens so that one obtains a series of narrow-scan XPS spectra representing increasingly oxidised states. This makes it easier to interpret the superposition of chemical states that existed in the original spectrum of an "as received" specimen, and indeed, to numerically extract spectra representing the pure components. This is not done *in situ* in the analyser, or *ex situ* outside the instrument, but rather *proxime situ* in the entry lock without having to take the sample out of the instrument. This allows Redox XPS to be done automatically and unattended, rather like a depth-profile. To be clear, this is not done to study the chemistry of UV or ozone exposure, but just to elucidate the chemical components of the specimen surface before that exposure.

After a brief review of the experimental arrangement we present a comprehensive analysis of spectral unmixing in Redox XPS, focusing on the treatment of spectra in the presence of the inelastic background. The study introduces novel approaches for analyzing narrow-scan XPS spectra of progressively oxidized samples, offering significant insights into the decomposition of complex spectral data into its constituent chemical states. By leveraging advanced computational techniques, this approach significantly improves the accuracy and reliability of chemical state identification in XPS analysis, and should address some of the important issues raised in the community recently regarding the reliability of peak-fitting performed by those new to XPS.

This progressive gas-phase oxidation offers even more opportunities in the understanding of SIMS spectra, given the more specific ozonolysis chemistry of complex organics. We look at the opportunities (with data - if we have it by December).

Thin Films and Surface Modification

Room Naupaka Salon 1-3 - Session TF-TuP

Thin Films and Surface Modification Poster Session I

TF-TuP-1 Effect of Ag Layer Thickness on the Transmittance and Conductivity of Transparent Antennas Fabricated Using ITO/Ag/ITO Structures, Yoji Yasuda, Y. Saitou, Tokyo Polytechnic University, Japan; *F. Koshiji,* tokyo polytechnic university, Japan; *T. Uchida,* Tokyo Polytechnic University, Japan

In recent years, research and development efforts have focused on the Internet of Things and next-generation communication systems. In these systems, antennas are ideally placed on the surface of the chassis to improve communication characteristics. Hence, to maintain the appealing design features of these devices and systems, optically transparent antennas using transparent conductive films such as indium tin oxide (ITO) are attracting attention. However, there is a trade-off relationship between the optical transmittance and conductivity of transparent conductive films, and it has been challenging to achieve a good balance between the two. Nevertheless, it has been reported that multilayer composites with a dielectric-metal-dielectric (DMD) structure, in which a metallic thin film (e.g., Ag thin film) is introduced as an intermediate layer, can simultaneously achieve high transmittance and conductivity. In this study, we evaluated the transmittance and conductivity of a DMD structure composed of ITO/Ag/ITO with respect to changes in the thickness of Ag in the intermediate layer, and investigated the effects of the transmittance and conductivity on the antenna characteristics following annealing treatment.

ITO/Ag/ITO transparent conducting films were deposited by varying the thicknesses of the Ag and intermediate layers using a facing target sputtering system. The films were annealed at 200–500 °C in air, and their optical transmittance and electrical properties, such as sheet resistance and carrier density, were evaluated. In addition, a monopole antenna of 20 mm length and 5 mm width was fabricated and its radiation efficiency was measured. It was found that with an Ag layer thickness of 7.5 nm, the transmittance and conductivity of the ITO/Ag/ITO film were approximately 69.8% and 7.8×10^5 S/m, respectively. When the transparent conducting film with an Ag film thickness of 7.5 nm was annealed at 200 °C, the transmittance and conductivity of the film increased to approximately 73.4% and 8.5×10^5 S/m, respectively.

TF-TuP-2 Extending the Lifetime of Plasma Torch Electrodes Using a Layer of Carbon Nanotubes, Alexandr Ustimenko, V. Messerle, Affiliation, Kazakhstan

The lifetime of plasma torch electrodes is critical, however it is usually limited to 200 hours. Considered in this paper the long life direct current arc plasma torch has the cathode life significantly exceeded 200 hours. To ensure the electrodes' long life a process of hydrocarbon gas (propane/butane) dissociation in the electric arc discharge is used. In accordance to this method, atoms and ions of carbon from near-electrode plasma deposit on the active surface of the electrodes and form a carbon condensate in the form of carbon nanotubes. It operates as "actual" electrode. To realize aforesaid the construction of a plasma torch using air as the plasma forming gas has been developed and tested. Propane/butane mixture is supplied to the zone of the arc conjunction to the copper water-cooled electrodes (cathode and anode). As a result inside the cathode cavity and internal surface of the anode medium of carbonic gas is formed. Linked with the arc in series, the magnetic coils 3 guaranty stabilization of the discharge on the electrodes. The processes of propane/butane molecules dissociation and carbon atoms ionization start with the rise in temperature. Arisen from ionization positive carbon ions deposit onto the electrodes surface under the influence of near-cathode decline in potential and form coating of the electrode condensate. This coating is "actual" cathode, deterioration of which is compensated by the flow of carbon ions and atoms. The coating thickness depends mainly on ratio of the flows propane/butane and air and the arc current. It is found that when power of the plasma torch was in interval 76–132 kW and propane/butane flow in range of 0.4–0.7 LPM thermal efficiency of the plasma torch reached 90%. At that mass averaged temperature on the exit of the plasma torch increased to 5000 K. The electrode condensate was examined using scanning electron microscopy, transmission electron microscopy and Raman spectroscopy. It is found that the electrode condensate is composite carbonic stuff made of carbon nano-clusters which consists mainly of single

and multi-wall carbon nanotubes. The following parameters of the conducting nano carbon deposited at the cathode were determined: chemical composition, wt %: C 96.74–98.47, H 2.26–1.24, Cu 1–0.30; interplanar spacing, nm: 0.333 (100%), 0.207 (1%), 0.168 (5%); apparent density, 1.63 g/cm³; and resistivity, <10⁻⁸ Ohm-m.

TF-TuP-3 Comparative Depth Analysis of Crystalline Phases in Copper Thin Films Using OrbiSims, Jong Sung Jin, J. Sung, Korea Basic Science Institute (KBSI), Republic of Korea

Copper thin films with different crystallinities of poly and single crystal were formed on sapphire with excellent crystallinity. The latest OrbiSims equipment was used to analyze the depth from the surface to the interface where the sapphire substrate is exposed, and the three-dimensional structure of various ions was confirmed. Three thin films with different crystallinities, including copper foil, were analyzed. The internal oxygen showed a clear difference in the relative content and distribution pattern between poly and single crystal. In addition, the behavior of aluminum ions contained in sapphire was different. Naturally, the distribution of copper ions, which are the main raw material, was also different. From the results of this study, we were able to simultaneously confirm the distribution of oxygen that can control the oxidation of thin copper films, the correlation with the crystallinity of copper, and the behavioral changes of ions using OrbiSims. We are confident that these observations will provide basic data for the modification of solid surfaces, such as the prevention of oxidation of copper surfaces and the coating of ions of other metals in the future.

TF-TuP-4 Surface Chemistry and Growth Characteristics of SiN_x Films via Plasma-Enhanced Atomic Layer Deposition, Ilkwon Oh, Ajou University, Republic of Korea

Recent advancements in semiconductor applications have emphasized the growing importance of SiN_x due to its exceptional operational reliability.[1,2] In the scaling trends, the need to deposit gate spacers has underscored the significance of SiN_x atomic layer deposition (ALD), which offers uniformity and conformality, and thickness control at the Angstrom level. [3, 4] However, the role of Si precursor chemistry in growth and electrical characteristics of SiN_x films has not been fully explored. Understanding this relationship is crucial, as growth characteristics directly impact the electrical performance and leakage current behavior of SiN_x, which is vital for its effectiveness in electrical insulation applications. This study investigates the relationship between three different Si precursors and the electrical properties of SiN_x films. Three alkyl amine precursors, bis(tertiarybutylamino)silane (BTBAS), bis(diethylamino)silane (BDEAS), and NSi-01 were used for this study. The deposition was done on the substrate temperature of 200 °C with 60 MHz very high frequency (VHF) N₂ plasma as a reactant. Density functional theory (DFT) calculations, Monte Carlo (MC) simulations, and ellipsometry were employed to analyze the growth characteristics during ALD process. Additionally, the film quality evaluation was done by using X-ray photoelectron spectroscopy (XPS), and transmission electron microscope (TEM). The correlation between electrical and growth characteristics was investigated by fabricating and evaluating metal-oxide-semiconductor (MOS) capacitors. This study provides key insights into optimizing precursor selection to enhance device performance, demonstrating how the choice of ligands can significantly impact the leakage characteristics and reliability of SiN_x-based devices.

References [1] Kern et al, Handbook of Thin Film Deposition Process and Techniques, 2, 11-43 (2001). [2] Woochool Jang et al, Physica Status Solidi, 212, 2785-2790 (2015). [3] F. Koehler, IOP conference Series: Materials Science and Engineering, 41, 012006 (2012). [4] Stacey F. Bent et al. Materials Today, volume 17, number 5 (2014).

TF-TuP-5 Enhanced Oxide versus Nitride Selectivity in Area-Selective Atomic Layer Deposition of SiO₂ Thin Films Combining Small Molecule Inhibitors with Atomic Layer Etching, Jiwoo Oh, J. Lee, W. Kim, Hanyang University, Korea

As the semiconductor industry advances towards complex multilayered devices with smaller features, area-selective atomic layer deposition (AS-ALD), a bottom-up method, has gained significant interest for its capability to enable precise and self-aligned deposition within specified areas, i.e., the growth areas. In this study, we primarily utilized small molecular inhibitors as vapor-phase deactivating agents to non-growth areas, due to their small size, high volatility, and ease of process integration into 3D structured devices. More particularly, this AS-ALD methodology is advantageous for manufacturing high aspect ratio SiO₂/SiN structures in V-NAND, where the reduction in tier size leads to cell-to-cell crosstalk between vertically downscaled SiO₂/SiN stacks. To mitigate this issue, it is essential to apply

Tuesday Afternoon, December 10, 2024

AS-ALD of SiO₂ thin films on SiO₂ surfaces while preventing deposition on SiN surfaces. For this purpose, we employed a vapor-dosing process using silane-based small molecule inhibitors that chemo-selectively adsorb on -NH terminated surface groups of the SiN surface. Moreover, to further improve deposition selectivity, we periodically introduced a post-atomic layer etching step with atomic scale fidelity after a certain number of ALD SiO₂ cycles, which effectively removed SiO₂ moieties from the SiN surfaces. Finally, we achieved a deposition selectivity greater than ~10 nm on blanket SiO₂ and SiN substrates. The approach we present here contributes to the advancement of the manufacturing process for next-generation bottom-up 3D nanofabrication.

TF-TuP-6 Conductive Polymer Film Formation Using Plasma Process in Organic Solution According to Driving Power Condition, *Hyojun Jang, J. Kim, H. Tae*, Kyungpook National University, Republic of Korea

Plasma material process in an organic solution uses the interaction between plasma and solution substances. Plasma generated in the solution occurs a strong discharge through an electrode structure designed for ease of ignition. Therefore, most plasma materials processes conducted in solution have been used to form metal or carbon nanoparticles by erosion of electrodes or carbonization of solutions. Recently, studies have been reported on igniting plasma that limits strong discharges in liquid phases and controlling chemical activity (oxidation, reduction) according to the driving waveform. As a result, this method succeeded in creating π -conjugated polymer film, as well as nanoparticles with the molecular structure of the starting solution.

In this study, we conducted research on controlling properties of conductive polymer films synthesized by the plasma process in organic solution. Plasma characteristics affect the chemical activity of the material and consequently change the properties of the polymer film. Therefore, this process is performed using various driving power conditions to control the plasma characteristics. The electrical and optical characteristics of plasma and the changes in solution are analyzed according to driving power conditions. Moreover, the differences in the properties of conductive polymer films are investigated in detail. Finally, it is confirmed that the conductive polymer synthesized in this method has stable electrical properties in room condition.

Thin Films and Surface Modification

Room Naupaka Salon 5 - Session TF1-TuE

Thin Films - Bio- and Medical-related

Moderator: Seo-Hyun Lee, Hanyang University

5:40pm **TF1-TuE-1 Advanced Surface Engineering for Mass-Produced Medical Diagnostic Technology Addressing Tomorrow's Global Public Health Challenges**, *Christopher Muratore, B. Robertson, M. Muratore*, University of Dayton; *N. Glavin*, Air Force Research Laboratory **INVITED** Materials with high surface-to-volume ratios demonstrate exquisite sensitivity and detection limits in diverse molecular sensing applications. Integration of nanowires, nanotubes, and two-dimensional (2D) semiconductors into sensing devices, however, presents challenges inhibiting product development. For example, thousands of trials are required to obtain US government approval for point of care diagnostics, yet producing a suitable number of 2D devices via conventional synthesis and fabrication techniques to meet this testing requirement is not currently feasible. To realize commercial applications of 2D transducers in ubiquitous low-cost diagnostic devices, new synthesis and fabrication approaches were developed. Processes for high-rate ($>10^6$ per day) mass-production of low-cost two-dimensional electronic medical diagnostic devices with limits of detection rivalling polymerase chain reaction (PCR) based techniques (<10 fg/mL) with response times of <2 minutes will be presented. Rapid and inexpensive sensor chip fabrication relies upon sputter deposition, laser patterning, and laser annealing processes in a roll-to-roll physical vapor deposition system. Moreover, naturally abundant and recyclable materials were selected for use in these scaled processes for reduced waste stream impact in anticipation of large numbers of devices are consumed daily. An automated high-speed Raman spectroscopy system was developed for quality control of mass-produced materials during fabrication. Fundamental studies employing this system to measure point defect densities in 2D semiconducting transducer materials will be shown to correlate synthesis and fabrication process parameters, 2D materials structure, and diagnostic device performance.

6:20pm **TF1-TuE-3 Development of Stretchable Plasma Patch using Kirigami Technique for Biomedical Applications**, *Sunghoon Jung, J. Kim*, Korea Institute of Materials Science, Republic of Korea

Plasma technology has recently been widely utilized in the biomedical field. Reactive oxygen and nitrogen species generated by plasma have been increasingly reported to sterilize pathogens and improve skin conditions. Traditional biomedical plasma devices include jet-type plasma sources and flexible patch-type plasmas. However, jet-type plasma is not suitable for large-area skin applications, and flexible plasma patches are not ideal for use on the stretchable surfaces of the human body. In this study, we employed the kirigami technique to impart stretchability to the existing plasma patch structure and applied it to pathogen removal.

The primary objective of this research is to develop plasma patches that naturally create discharge spaces and possess mechanical stretchability through the kirigami technique. This allows for effective plasma discharge and ozone generation without the need for additional spacers, even when deformed.

Plasma patches with 30%, 50%, and 100% stretchability were fabricated using screen printing and laser cutting technique. The discharge characteristics and ozone generation properties were evaluated in both non-attached states (large discharge space), where the patches were suspended in open space, and attached states (very small discharge space), simulating skin attachment.

In the non-attached state, where the patches were suspended in open space, the kirigami patches exhibited similar discharge characteristics to non-stretchable patches. However, when attached to a substrate, non-stretchable patches failed to generate plasma due to the lack of discharge space. In contrast, the kirigami patches, when stretched, caused the electrodes to rotate diagonally, creating discharge spaces and enabling plasma generation. This demonstrates that kirigami patches can achieve effective plasma discharge without additional spacers. Furthermore, antibacterial experiments confirmed the efficacy of the patches in eliminating *Escherichia coli* and *Staphylococcus aureus*.

The kirigami-based stretchable plasma patches offer significant advantages for biomedical applications, particularly in skin treatments. The ability to generate plasma without the need for additional spacers and the successful

elimination of bacteria highlight the high potential of these patches. Future work will focus on optimizing the design and exploring further biomedical applications.

6:40pm **TF1-TuE-4 Silver-Copper Coatings: Combating Microbes on Surfaces and in Air Filtration**, *L. Reyes-Carmona*, UNIVERSIDAD NACIONAL AUTONOMA DE MEXICO, CU, Mexico; *V. Perez-Bucio, A. Almaguer-Flores*, UNIVERSIDAD NACIONAL AUTONOMA DE MEXICO; *O. Sepulveda-Robles*, Instituto Mexicano del Seguro Social, Mexico; *Sandra E Rodil*, UNIVERSIDAD NACIONAL AUTONOMA DE MEXICO **INVITED**

The significant risk posed to healthcare workers by the transmission of bacteria and respiratory viruses through expelled saliva microdroplets and aerosols, underscored by the SARS-CoV-2 pandemic, has driven researchers to develop nanomaterials with antimicrobial properties for respiratory protection equipment like facemasks, respirators, and air filtration systems. Beyond medical doctors, odontologists are continually exposed to bioaerosols that may contain viruses or bacteria. This study introduces SakCu[®], a silver and copper nanolayer applied to one side of spun-bond polypropylene fabric using the magnetron sputtering technique. The antibacterial and antiviral properties of the AgCu nanolayer were tested against droplets landing on the material and aerosols passing through it.

The effectiveness of the nanolayer was rigorously assessed through viability assays using respiratory surrogate viruses, ssRNA Leviviridae, and ssDNA Microviridae as representatives of non-enveloped viruses. Colony-forming unit (CFU) determinations were used to evaluate the survival of four aerobic and four anaerobic bacteria, as well as multiple species present in subgingival biofilm samples taken from patients with periodontitis.

Viability assays with surrogate viruses showed significant reductions in viral replication within 2-4 hours of contact. A simulated viral filtration system demonstrated inhibition of viral replication ranging from 39% to 64%. PhiX174 viability assays showed a 2-log reduction in viral replication after 24 hours of contact and a 16.31% inhibition in viral filtration assays. Bacterial growth inhibition varied by species, with reductions ranging from 70% to 92% for aerobic bacteria and over 90% for anaerobic strains. Regarding the viability of microorganisms from the subgingival biofilm samples, a $57.8 \pm 9.7\%$ reduction was observed when the samples were in contact with the AgCu nanolayer.

In conclusion, the AgCu nanolayer demonstrated robust bactericidal and antiviral activity under both contact and aerosol conditions. These findings suggest that the nanolayer has significant potential for incorporation into personal protective equipment, effectively reducing and preventing the transmission of aerosol-borne pathogenic bacteria and respiratory viruses in real-world settings.

Thin Films and Surface Modification

Room Naupaka Salon 5 - Session TF2-TuE

Thin Films - Processing

Moderator: Christopher Muratore, University of Dayton

7:40pm **TF2-TuE-7 Guided Combinatorial Synthesis, High-Throughput Materials Characterization and Machine Learning Methods Expedite the Discovery of Improved Pt-Au Thin Films**, *David Adams, T. Shilt, R. Kothari, K. Dorman, C. Martinez, C. Sobczak, S. Addamane, M. Jain, F. DelRio, M. Rodriguez, B. Boyce, R. Dingreville*, Sandia National Laboratories

Sputter-deposited Pt-Au thin films have been reported to develop a stable, nanocrystalline structure that exhibits high hardness and exceptional resistance to fatigue damage, yet little is known about how these characteristics vary with PtAu_{1-x} composition and process conditions. Toward this end, we describe an extensive combinatorial Pt-Au thin film library

which spans large ranges of binary stoichiometry and deposition atomistics.

Our approach to combinatorial material synthesis implements confocal magnetron sputtering of two elemental sputter targets. Kinematic Monte Carlo SIMTRA simulations helped guide efficient experiments that achieved a broad range of composition of PtAu_{1-x} (from $x \sim 0.02$ to 0.93) in relatively few (i.e., 3) depositions. The produced films were subsequently characterized using high-throughput, ex-situ methods to further accelerate materials discovery. Automated nano-indentation, X-ray reflectivity, X-ray diffraction, Atomic Force Microscopy, surface profilometry, four-point probe sheet resistance techniques, and Wavelength Dispersive Spectroscopy determined how hardness, modulus, density, surface roughness, structure, and

Tuesday Evening, December 10, 2024

resistivity vary with film stoichiometry and process parameters.

Combinatorial Pt-Au films displayed an assortment of properties with the hardness of some films exceeding values reported previously for this material system. High hardness, high modulus, and low resistivity were generally attained when using increased deposition energy and reduced angle-of-incidence processes. Finally, we discuss a machine learning approach trained on this complex combinatorial space, which offers new insights into our understanding of these films. An unsupervised clustering algorithm based on variational inference was implemented to encode the different modalities into a shared latent representation. Through analysis of this representation, we identified distinct mechanistic regimes with correlations across modalities. Overall, these efforts help pinpoint promising, new PtxAu1-x compositions for

future study and reveal strategies for improved deposition.

Sandia National Laboratories is managed and operated by NTESS under DOE NNSA contract DE-NA0003525. SAND2024-10392A

8:00pm **TF2-TuE-8 Dynamic Fracture of Copper/silica interfaces**, *Cristian Ciobanu*, Colorado School of Mines and NIST; *F. Bobaru*, University of Nebraska-Lincoln, USA; *G. Stan*, National Institute of Standard and Technology, Gaithersburg, Maryland 20899 USA

Within the real of recent efforts to address new challenges in semiconductor packaging, the hybrid bonding between a dielectric (e.g. silica) and a metal (usually copper) occupies a special place. This direct bond interconnect holds the key to superior functionality, high-density packaging, and low-power operation of future semiconductor devices. However, as the dimensions of the copper interconnects decrease, preparing high quality hybrid bonding that withstands further processing or packaging becomes a challenge. At micron or submicron dimensions, the copper pads or bumps may debond from the silica matrix, which can compromise at least the mechanical integrity of the packaging. In this work, we present a study of dynamic fracture in a heterogeneous system consisting of a copper pad embedded in a silica matrix using peridynamics simulations based on the Fast Convolution-Based Method (FCBM) for spatial discretization and an explicit time marching scheme. Depending on the interface bonding energy, we show different cracking scenarios encountered when a crack initiated in the matrix propagates towards and through the metal inclusion. Crack propagation around the inclusion is consistent with low bonding energy, and we use the simulations to map out the acceptable bonding ranges for different loadings, i.e. those for which cracks propagate through (rather than around) the interface. These results may provide guidance in understanding the cracking of single or multiple pads, and can help estimate acceptable ranges of bonding energy, pad dimensions, and packing density (pads per area).

8:20pm **TF2-TuE-9 Maskless Localized Atomic Layer Deposition Applied to Surface Functionalization**, *T. Souvignet*, *J. Carlotti*, *V. Salles*, *M. Maillard*, *Catherine Marichy*, Laboratoire des Multimatériaux et Interfaces - Université Claude Bernard Lyon 1, France

Nowadays, interest in surface engineering is strongly expanded in many domains like nanoelectronics, energy, transportation, medicine, and the environment. Especially, precise (micro-) surface functionalization patterning are sought after for many devices and applications such as self-cleaning surfaces, microfluidic devices, moisture harvesting and anti-fogging coatings as well as bio-sensor, bio-microarray, and efficient water management in fuel cell.

Maskless fabrication approaches are highly attractive as they enable rapid prototyping of surface functionalities. Based on self-limiting surface reactions, Spatial Atomic Layer Deposition (SALD) technique has recently enabled localized deposition with a control of the film thickness at the atomic scale.⁽¹⁻⁴⁾

Using a modified open-air SALD head, we successfully demonstrated the maskless deposition of uniform and homogenous oxide thin films with a lateral resolution tuned from millimeters to hundred micrometers range while keeping a film thickness in the range of a few to hundreds of nanometers with a control at the nanoscale.⁽⁴⁾

Herein, surface functionalization using of this maskless SALD approach is introduced. From alkyl silane, it is indeed possible to locally modify the surface properties (hydrophilic/hydrophobic character, etc.) by grafting monolayers, without change of surface topography. Tuning the functionalization degree/saturation of the grafting sites is achieved to modulate the hydrophobic character of the patterns. Contact angles and surface energies are determined before and after functionalization. On patterns, gradient of composition occurs that induces a controllable

gradient of hydrophobicity, as demonstrated by the presence of a wetting hysteresis. Imprinted gradients in wettability are particularly interesting for controlling the dropwise condensation of vapor and drop displacement.

1. C. A. Masse de la Huerta *et al.*, *Advanced Materials Technologies*. **5**, 2000657 (2020).
1. P. Poedt, B. Kniknie, A. Branca, H. Winands, F. Roozeboom, *physica status solidi (RRL) – Rapid Research Letters*. **5**, 165–167 (2011).
1. M. Aghaee, J. Verheyen, A. A. E. Stevens, W. M. M. Kessels, M. Creatore, *Plasma Processes and Polymers*. **16**, 1900127 (2019).
1. L. Midani, W. Ben-Yahia, V. Salles, C. Marichy, *ACS Appl. Nano Mater.* **4**, 11980–11988 (2021).

8:40pm **TF2-TuE-10 Advanced Atomic Level Patterning Process by Area Selective Atomic Layer Deposition Integrating Atomic Layer Etching**, *Seo-Hyun Lee*, *J. Lee*, *J. Oh*, *W. Kim*, Hanyang University, Korea

As semiconductor devices continue to be miniaturized, the reduction in the width of their components has become significant, prompting increased research into 3D structured patterns. Traditional optical lithography-based patterning methods, though commonly utilized, face challenges such as complex processing steps, escalating costs, and difficulties in achieving patterns below 10 nm. To overcome these limitations, we have explored the use of area-selective atomic layer deposition (AS-ALD), a bottom-up thin film deposition technique, which enables selective growth of thin films in specified regions. A malonate-based inhibitor was introduced in the gas phase to deactivate non-growth regions, *i.e.*, SiN substrates, allowing SiO₂ thin films to grow selectively via ALD only on growth regions, *i.e.*, SiO₂ substrates. However, the AS-ALD process often results in unintended deposition of ALD films in non-growth regions, thereby compromising the selectivity between growth and non-growth regions. To address this issue, a post-etching process using atomic layer etching (ALE) was implemented to remove the undesired SiO₂ films deposited on the SiN substrates. Through a repeated sequence of inhibitor exposure, SiO₂ film deposition, and post-etching, we precisely achieved deposition selectivity of 10 nm-thick SiO₂ films, confined exclusively to the SiO₂ substrates. Furthermore, this deposition selectivity was also achieved when applying the sequences to a patterned SiO₂/SiN substrate, demonstrating its suitability for versatile use in upcoming semiconductor devices. This methodology can be leveraged for application in 3D NAND fabrication processes, particularly utilizing the results obtained on SiO₂ and SiN substrates.

Thin Films and Surface Modification

Room Naupaka Salon 1-3 - Session TF-WeP

Thin Films and Surface Modification Poster Session II

TF-WeP-1 Annealing Temperature Effects on Liquid Crystal Behavior and Electro-Optical Properties in Inorganic Alignment Films, *H. Lee, J. Sim*, Ulsan National Institute of Science Technology, Republic of Korea; **Hong-Gyu Park**, Changwon National University, Republic of Korea

Aligning liquid crystal molecules in a single direction is essential for achieving a uniform and clear display. Additionally, research on the application of new alignment films and methods to enhance the optical, thermal, mechanical, and chemical stability of liquid crystal alignment is ongoing. In this study, we observed the changes in liquid crystal behavior and the resulting electro-optical properties in high-k inorganic alignment films depending on the annealing temperature. While conventional polyimide alignment films are typically annealed at 230°C, we examined how the characteristics of the inorganic films used in this study changed with annealing temperatures of 100°C, 150°C, and 200°C. This allowed us to explore the feasibility of low-temperature processing with inorganic alignment films and to assess their potential as a replacement for traditional polyimide alignment films.

TF-WeP-2 Localized Physical and Chemical Manipulation of Surfaces via Thermal Scanning Probe Lithography (t-SPL), *Nicholas Hendricks, E. Çağın*, Heidelberg Instruments Nano AG, Switzerland

Modification of thin film surfaces is of the utmost importance for various applications ranging from biosensors and spintronics to flat optics and magnonics. To push the performance of such applications to the next level, the optical, electrical, chemical, or magnetic properties need to be locally controlled at the sub-50nm length scale. To convert thin film surfaces, the use of direct-write lithography techniques is often employed where the film is manipulated by electrons, photons, or ions. These energetic particles can induce physical and chemical changes, however, the direct use of thermal energy as the stimulus could provide a more universal stimulus as well as an alternative route for such modifications. With thermal scanning probe lithography (t-SPL), enabled by the NanoFrazor from Heidelberg Instruments, the use of heat to perform direct-write patterning conversions is possible [1-5].

t-SPL generates patterns by scanning an ultrasharp tip over a sample surface to induce local changes with a thermal stimulus. By using thermal energy as the stimulus, it is possible to perform various conversion processes such as functional surface group deprotection, precursor conversion, and crystallization. Along with an ultrasharp tip, with a radius less than 10nm, the t-SPL cantilever contains several other important functions such as an integrated thermal height sensor, a capacitive platform for electrostatic activation, and an integrated heating element. By having a cantilever with such properties, it's possible to generate 2D and grayscale chemical gradients where surface chemistry is critical.

In this presentation, the background and workings of t-SPL will be introduced along with the lithography and processing steps necessary to create chemical gradients through the deprotection of functional groups for enzyme and protein patterning. The patterning of a phase change material (PCM) of GeSbTe (GST) will also be discussed where sub-300nm phase changes have been optically observed.

1. S. Howell et al., *Microsystems & Nanoengineering*, 6, 21 (2020)
2. Y. Meng et al., *Adv. Mater.* 32, 2005979 (2020)
3. V. Levati et al., *Adv. Mater. Technol.* 8, 2300166 (2023)
4. O. J. Barker et al., *Appl. Phys. Lett.*, 124, 112411 (2024)
5. Riedo et al., <https://doi.org/10.21203/rs.3.rs-3810461/v1>

TF-WeP-3 Synaptic Characteristics of Memristive Au/LiNbO₃/Pt Device Based on Schottky Barrier Modulation, *Sejoon Lee, Y. Lee, D. Kim*, Dongguk University, Republic of Korea

The (113) LiNbO₃ layers were grown onto the (111) Pt/SiO₂/Si substrates at 180 – 320 °C by radio-frequency magnetron sputtering. The samples grown at 250 °C displayed the improved crystallinity as well as the smooth surface morphology without any hillocks and pits. The memristive devices, fabricated in the form of the top-to-bottom Au/LiNbO₃/Pt two-terminal device scheme, clearly exhibited the external electric field polarity-dependent asymmetric memristive hysteresis loops in their current-voltage characteristic curves. When repeating the current-voltage sweep at an appropriate program voltage range, the on-state current was gradually

increased with increasing sweep number. Through analyzing the transport mechanism in Au/LiNbO₃/Pt, such a behavior was confirmed to be attributable to the Schottky barrier modulation, arising from the ionic migration of oxygen vacancies inside the LiNbO₃ layer. In other words, the electro-migrated oxygen vacancies in LiNbO₃ lead to the Schottky barrier modulation particularly at the LiNbO₃/Pt side; and it eventually gives rise to the switchable diode effect in the Au/LiNbO₃/Pt device. Since the degree of the switchable diode effect relies on the pulse parameters of the applied voltage stresses, the memristive characteristics (e.g., data storage speed, multiple resistance states, data retention, etc.) could be effectively controlled by changing the pulse magnitude and the pulse duration of the program/erase voltages. Using these unique features, various synaptic functions such as a short-term memory, long-term potentiation/depression, and spike-timing dependent plasticity were effectively demonstrated. The results suggest that the LiNbO₃ based memristors hold great promise for the future neuromorphic applications.

[1] J. Wang *et al.*, *Adv. Electron. Mater.* 9, 2201064 (2023)

[2] J. Wang *et al.*, *Adv. Intell. Syst.* 5, 2300155 (2023)

TF-WeP-4 X-Ray Photoelectron Spectroscopy and X-Ray Emission Spectroscopy Data Fitting Using a Genetic Algorithm, *Alaina Humiston, J. Terry*, Illinois Institute of Technology

The ever-growing problem in modern science is that data is being collected at a rate faster than analysis can be performed by characterization experts. The analysis that is done for many recently published x-ray photoelectron spectroscopy (XPS) and x-ray emission spectroscopy (XES) data, is often incorrect/irreproducible and leads to a cycle of incorrect fits in this spectroscopy data. In this work, a genetic algorithm (GA) is being constructed to potentially minimize this human error. This GA code known as XPS Neo/XES Neo, is based on the Neo package which exists for EXAFS (EXAFS Neo) and Nanoindentation (Nano Neo) data. GAs are based on biological methods and depend on parameters such as populations size, number of generations, genes, crossover, and mutation. The GA takes in a certain population size and constructs individual vectors each with their own unique genes i.e the fitting parameters we are trying to optimize. It then performs crossover and mutation to these individual vectors to progress toward a lower global minimum. This GA allows for a variety of mutation options including, Random Perturbations, Rechenberg, Metropolis mutation, and Self Adapting Differential Evolution. The methods of how a GA works in relation to XPS and XES datasets are discussed. The difficulties in making this work for XPS data arise from complicated backgrounds due to many effects such as plasmon loss, Auger peaks, and satellite peaks. XPS and XES data can also have many peaks that are difficult to distinguish from one another. Currently, the algorithm is only able to fit simplistic XPS spectra such C, O, N, and Si and is being worked on with the hopes of it becoming applicable for more difficult data. The goal is to make the algorithm applicable to all XPS data, with a greater focus given to the actinides, specifically for the use of fitting plutonium data as analysis of this spectra is highly sought after and difficult to fit. Through proper use of an informed GA, and collaboration with the XPS/XES database website XPSOasis.org, theoretically correct fitting of this data is hoped to be achieved.

TF-WeP-5 Synaptic Characteristics of Au/Hf_xZr_{1-x}O₂/Pt Memristors Based on Double-Barrier Schottky Junctions, *Youngmin Lee, S. Lee, D. Kim*, Dongguk University, Republic of Korea

The Hf_xZr_{1-x}O₂ layers were grown onto the (111) Pt substrates at 450 °C by radio-frequency magnetron sputtering, and were annealed at 600 – 800°C. The 700°C-annealed samples showed a smooth surface and an improved orthorhombic lattice phase. The Hf_xZr_{1-x}O₂ layers exhibited the nonlinear lossy-type ferroelectric characteristics, by which the degree of ferroelectric polarization and its appropriate data retention can be gradually adjustable. The memristive devices, comprising the top-to-bottom Au/Hf_xZr_{1-x}O₂/Pt two-terminal device scheme, clearly displayed the ferroelectric polarization-dependent asymmetric hysteresis behaviors in their resistive switching characteristics. When repeating the current-voltage sweep at a certain and moderate voltage range, the on-state current was gradually increased with increasing sweep number. This could be attributed to the Schottky barrier modulation at the Hf_xZr_{1-x}O₂/Pt side. Since the repeated voltage stresses at the Au/Hf_xZr_{1-x}O₂ biased region would tenaciously increase the ferroelectric polarization field inside the Hf_xZr_{1-x}O₂ layer, the increased potential gradient along the Au-Hf_xZr_{1-x}O₂-Pt direction could also increase. Then, the effective Schottky barrier height at the grounded Hf_xZr_{1-x}O₂/Pt side will eventually decrease upon increasing the ferroelectric

polarization field inside the $\text{Hf}_x\text{Zr}_{1-x}\text{O}_2$ layer. Since the ferroelectric polarization strongly depends on both the magnitude and the duration of the applied voltage pulses, gradual Schottky barrier modulation could be easily accomplished by controlling the pulse parameters. Furthermore, due to the ferroelectric nature in $\text{Hf}_x\text{Zr}_{1-x}\text{O}_2/\text{Pt}$, the Schottky emission rate could be retained at every modulated Schottky barrier heights. This eventually enabled the fine and precise control of the multiple memristive resistance states. Using these unique characteristics, we successfully demonstrated various synaptic functions such as excitatory post-synaptic current, paired pulse facilitation, long-term potentiation/depression, and spike-timing dependent plasticity. The results depict that the present memristive device scheme of the ferroelectric $\text{Hf}_x\text{Zr}_{1-x}\text{O}_2$ -based double-barrier Schottky junction holds substantial promise for the future neuromorphic applications.

[1] S. Song *et al.*, *Adv. Mater. Technol.* **7**, 2101323 (2022).

[2] B. Chen *et al.*, *Nanotechnol.* **34**, 505205 (2023).

TF-WeP-6 Isotope Labeling Study of CO₂ Formation Pathways in CO-H₂O Ice Films under Ultraviolet Irradiation, Koichiro Yamakawa, A. Hirayama, I. Arakawa, Japan Atomic Energy Agency, Japan

Molecular clouds are composed of gases and interstellar dust grains. The dust grains are covered with ice mantles predominantly composed of H_2O [1]. When the densities of the clouds increase up to 10^4 cm^{-3} or more and their temperatures drop below 20 K, CO is condensed on H_2O -rich ice. The ice mantles are exposed to ultraviolet (UV) radiation, which causes a variety of photochemical reactions. CO_2 is one of the abundant molecules in the ice mantles, and the following two formation channels have been discussed [2]: (1) reaction of two CO molecules, one of which is electronically excited by UV light; (2) reaction of CO with the OH radical which is a dissociation product of H_2O . We focused on the fact that these two channels can be distinguished from each other by isotope labeling, i.e., by employing H_2^{18}O instead of H_2^{16}O . In the present study, we investigated the UV photolysis of CO-H₂O ice and determined the effective rates of the CO_2 formation channels with use of isotope labeling and infrared spectroscopy [3].

A CO gas and an H_2^{18}O vapor were mixed in a gas handling system. The mixing ratio was changed in the range of $\text{CO}/\text{H}_2^{18}\text{O} = 1000\text{-}0.1$. The gaseous mixture was introduced into an ultrahigh vacuum chamber and was condensed on a gold substrate cooled down to 10 K. After the condensation, the CO-H₂¹⁸O ice was irradiated with UV light from a deuterium lamp for 120 min. Reflection-absorption infrared spectra were recorded during the condensation and UV-irradiation.

After the UV irradiation of any sample, we detected infrared absorption bands of C^{16}O_2 (2346 cm^{-1}) and $\text{C}^{18}\text{O}^{16}\text{O}$ (2328 cm^{-1}), which were generated through the CO-CO and CO-H₂O reactions, respectively. The absorption band of C^{18}O_2 was also detected at 2308 cm^{-1} when the mixing ratio was in the range of $\text{CO}/\text{H}_2^{18}\text{O} = 100\text{-}0.1$. This indicates that the photodissociation and regeneration of CO_2 took place in ice. We analyzed the irradiation-time dependence of the C^{16}O_2 and $\text{C}^{18}\text{O}^{16}\text{O}$ column densities to determine the effective cross sections of the CO_2 formation through the CO-CO and CO-H₂O reactions simultaneously.

References

[1] E. L. Gibb *et al.*, *Astrophys. J. Suppl. Ser.* **151**, 35 (2004).

[2] N. Watanabe and A. Kouchi, *Astrophys. J.* **567**, 651 (2002).

[3] A. Hirayama, I. Arakawa, and K. Yamakawa, *Astrophys. J.* **951**, 132 (2023).

Thin Films and Surface Modification

Room Naupaka Salon 4 - Session TF1-WeE

Thin Films - Properties

Moderator: Tetsuhide Shimizu, Tokyo Metropolitan University

5:40pm TF1-WeE-1 Superlubricity: Toward Design of Zero-Friction and Zero-Wear Materials, *Diana Berman*, University of North Texas **INVITED**

Friction and wear-related failures remain the greatest problems in today's moving mechanical components, from microelectromechanical devices to automotive assemblies and to biological systems. The critical need to reduce and eliminate the tribological failures constitutes the necessity for continuous search of novel materials and lubrication solutions. In this presentation, we overview recent advances in establishing the fundamental understanding of materials interactions at sliding interfaces and use this knowledge as a guide to developing nanomaterials solutions that enhance reliability and efficiency of tribological systems. We evaluate tribological performance of 2D materials, including graphene, molybdenum disulfide, and MXene, and demonstrate realization of superlubricity regime at macroscale. To extend the lifetime of the tribological materials, we demonstrate tribochemically-driven self-replenishment of materials inside the contact interfaces, thus enabling a zero-wear sliding regime.

Overall, the findings have not only allowed us to solve some long-standing puzzles, but could also open a new avenue for the development of new concepts and design strategies for next generation of tribologically efficient materials systems.

6:20pm TF1-WeE-3 Langmuir Monolayer Studies of First-Generation Photoswitchable DASA Surfactants, *H. Kaur*, University of Saskatchewan, Canada; *S. Sumat, S. Murphy*, University of Regina, Canada; *Matthew Paige*, University of Saskatchewan, Canada

Donor-Acceptor Stenhouse Adducts (DASAs) are photochromic molecules that can be isomerized with visible light between a coloured, linear triene form to a colourless cyclic form. These compounds have garnered considerable interest for a variety of light-based applications in the field of photopharmacology and related fields. In this work, we have synthesized several first-generation DASAs with a barbituric acid-based acceptor and a dialkyl amine donor, and investigated how the chemical structure of the DASA affects fundamental structural properties of Langmuir films they form. The DASAs form stable monolayer films at the air-water interface and exhibit a classical LE-LC phase transition at room temperature. Photoillumination leads to a significant alteration in film packing, along with spectroscopic changes consistent with successful isomerization between triene and cyclic form. Film morphology at the air-water interface is also significantly impacted by the photoisomerization process, as assessed by *in situ* Brewster Angle Microscopy. We have also explored the ability to deposit films as both monolayers and multilayers onto solid substrates and characterized the deposition process efficiency and resulting film structures using a variety of techniques. Time allowing, the structure and orientation of the DASA headgroup at the air-water interface will be discussed in context of appropriate molecular modeling calculations.

6:40pm TF1-WeE-4 Highly Transparent, Colorless Optical Film with Outstanding Mechanical Strength and Folding Reliability Using Mismatched Charge-Transfer Complex Intensification, *Sung Woo Hong*, Korea Institute of Industrial Technology (KITECH), Republic of Korea

The development of flexible, transparent, and colorless optical films with exceptional mechanical properties is of great interest to the advancement of flexible displays and electronics. In this study, we develop a new highly transparent, colorless optical film with outstanding mechanical strength and folding reliability for flexible displays and electronics.

Employing the concept of mismatched charge-transfer complex intensification, the newly developed optical film shows a tensile modulus of over 10 GPa, total transmittance close to 90%, and a yellow index below 3.0. To our knowledge, this is the best-recorded balance between mechanical strength and optical properties for a highly flexible optical film.

In addition, it has a superior pencil hardness grade (3H) compared to that of commercially available optical-grade engineering plastic films (under 4B). More importantly, it exhibits exceptional mechanical durability and folding reliability for over 300,000 folding/unfolding cycles at a radius of 1.5 mm, outperforming commercially available optical-grade engineering plastic films and conventional glass substrates.

These remarkable properties are attributed to a unique supramolecular structure with multiple hydrogen bonding and salt complexation

interactions, which exhibits CTC intensification. We also propose a mechanism to explain the concept of mismatched CTC intensification.

In summary, our study provides valuable insights into developing highly flexible films with significantly improved optical properties, mechanical bulk and surface strength, mechanical durability, and folding reliability for next-generation flexible displays and electronics. Our findings also offer new possibilities for the design of advanced flexible displays and electronics, with potential applications in various fields, such as wearable devices, biomedical sensors, and flexible solar cells.

7:00pm TF1-WeE-5 Precise Synthesis of Covalent Organic Framework Thin Films, *Dong Wang*, Institute of Chemistry, Chinese Academy of Sciences, China

The exotic properties associated with graphene and other 2D layered inorganic materials have attracted great interests from a variety of research fields. Two-dimensional covalent organic frameworks (2D COFs), which are covalently constructed from planar aromatic building blocks based on the principles of reticular chemistry, are a class of porous crystalline material with the highly ordered porous architectures and pre-designable electronic skeletons. 2D COFs feature the extended conjugation within a 2D layer and periodically columnar arrays aligned with an atomic precision in vertical direction, which is hardly achievable in other molecular architectures. In this context, high crystallinity and closely eclipsed stacking alignment of aromatic moieties render 2D COF as an ideal platform for charge carrier transport. With the improved crystallinity and controllable orientation, substrate supported 2D COF film would enable fabrication of advanced architectures for electronic devices, which however remains unexplored so far.

Herein, we report the on surface synthesis of high quality 2D COF thin film. We have developed a general method for constructing COF monolayers and thin films on substrate surfaces based on gas-solid and liquid-solid interfacial reactions. We proposed a method to improve 2D polymer orderliness by remotely modulating the molecular conformation through the effect of steric hindrance. We developed a chemical vapor deposition method, and prepared highly ordered 2D polymer films with controllable number of layers by modulating the kinetic process of the reaction. We further demonstrate that it is possible to fabricate COF thin film for optoelectronic device. Two types of field-effect transistors with horizontal and vertical structures were constructed by directly growing COF films on the surfaces of hexagonal phase boron nitride and monolayer graphene, respectively, and their in-plane transverse charge transport properties and electronic properties in the π - π stacking direction were investigated. We have constructed COF-based electrochromic devices, and the highly ordered structure of COF significantly enhances their performance such as response speed.

[1] Q. Hao, Z.-J. Li, C. Lu, S. Bing, Y.-W. Zhong, L.-J. Wan, D. Wang. *J. Am. Chem. Soc.* 2019, 141, 19831-19838.

[2] Q. Hao, Z.-J. Li, B. Bai, X. Zhang, Y.-W. Zhong, L.-J. Wan, D. Wang. *Angew. Chem. Int. Ed.* 2021, 60, 12498-12503.

[3] X.-R. Ren, B. Bai, Q. Zhang, Q. Hao, Y. Guo, L.-J. Wan, D. Wang. *J. Am. Chem. Soc.* 2022, 144, 2488-2494.

[4] Q. Hao, X.-R. Ren, Y. Chen, C. Zhao, J. Xu, D. Wang, H. Liu. *Nat. Commun.* 2023, 14, 578.

Thin Films and Surface Modification

Room Naupaka Salon 4 - Session TF2-WeE

Thin Films - Materials II

Moderator: Diana Berman, University of North Texas

7:40pm TF2-WeE-7 On the Growth of Cubic Boron Nitride Thin Films Using High-Power Impulse Magnetron Sputtering, *Tetsuhide Shimizu*, *H. Nagakura*, Tokyo Metropolitan University, Japan; *Y. Tokuta*, Tokyo Metropolitan Industrial Technology Research Institute, Japan; *I. Fernandez*, Nano4Energy, Spain; *R. Boyd*, Linköping University, Japan; *D. Lundin*, *U. Helmersson*, Linköping University, Sweden **INVITED**

To realize the growth of cubic boron nitride (c-BN) towards a full-scale industrial application of this coating materials, this work has been aimed to understand the discharge physics and growth kinetics in reactive high-power impulse magnetron sputtering (HiPIMS) of B_4C target in Ar/N_2 gas mixtures. Besides the developments of hard transition metal nitride coatings, c-BN coatings have been attracted because of its extremely high hardness, high thermal conductivity, high temperature resistance above

Wednesday Evening, December 11, 2024

1000°C, and inertness to steel materials. Although a wide variety of deposition processes have been studied since 1990s, it has not yet been commercialized. One of the major challenges is the significant degradation of film adhesion due to the high residual stresses during the cubic phase formation. While the key to nucleation of the c-BN phase is the formation of “nano-arches” by ion bombardment on the turbostratic BN phase (t-BN), the bombardment by the gas ions, such as Ar⁺ ions, leads to the entrapment of the gas atoms into the crystal lattice, causing the increase in residual stress. On the other hand, the time-transient discharge of HiPIMS makes the time separation of ion arrivals to the substrate and it enables the tuning of the incident ions and the independent control of their kinetic energy by using the synchronized pulsed substrate bias technology. This would realize the selective ion bombardment of film forming species, which is expected to result in efficient momentum transfer without introducing film stress through the rare gas incorporation. In addition, this great feature of the HiPIMS discharge allows us to systematically isolate the influencing factors and will dramatically advance the understanding of the nucleation physics of c-BN. In this study, the effects of ion acceleration schemes, including DC bias, synchronized pulsed bias and bipolar pulse configurations and their process parameters, such as the pulse duration, delay time and the substrate bias potential are thoroughly investigated, based on the mass-spectroscopy study of reactive HiPIMS discharge of B₄C target in Ar/N₂ gas mixture. In addition to the great importance of the bias potential, the obtained results clearly show the effect of the synchronized pulse duration and the time delay on the chemical bonding states of B-C-N films and its mechanical properties, due to the time domain of accelerated ions during film growth. By focusing on the average momentum transfer per deposited atom at each biasing condition, the role of the mass and flux of the incident ions on the formation of c-BN bonding state is discussed.

8:20pm **TF2-WeE-9 Physical Properties of Pure Vanadium Nitrides Thin Films**, *Marjorie Cavarroc, J. Neyrat, Safran, France; D. Marquez, D. Michau, A. Poulon-Quintin, ICMCB, France*

Transition metal nitrides coatings are widely studied because of their good optical, mechanical, thermal... properties. Depending on the microstructure, coatings present different properties. For vanadium nitride (VN), stable and metastable phases can be deposited as coatings. In this study, their physical and adherence properties on 316L stainless steel and AlN substrates depending on the microstructure and the thin film PVD technique used, are compared. Both Reactive High Power Impulse Magnetron Sputtering (R-HiPIMS) and Reactive RadioFrequency Magnetron Sputtering (RF-MS) were selected. Characterisations of structures and films microstructures were realised by *Grazing Incidence X-Ray diffraction* and *Electron Microscopies* (SEM and TEM). Scratch tests and nanohardness measurements were used to compare adherence and mechanical properties. Optical properties were explored with a four-point probe.

The correlation between microstructure, process and physical properties is discussed. The aim of this study is to show the interest for specific applications of VN thanks to the quantification of its physical properties and/or tuning its microstructures.

8:40pm **TF2-WeE-10 Sputter Depth Profile Study of ZrN as a Barrier to Silver Migration in Triso Fuels Using the XPS Neo Artificial Intelligence Fitting Package**, *Jeff Terry, Illinois Institute of Technology*

We have measured simulated TRISO Fuel model structures of SiC and ZrN with and without a 2 nm carbon capping layer. We have used both Sputter Depth Profiling with conventional X-ray Photoemission (XPS) and Ambient Pressure X-ray Photoemission Spectroscopy (APXPS) to explore the reactivity of these layers with both Ag and H₂O. One set of the samples that were depth profiled were measured at room temperature. Another set was annealed to 500 °C and then cooled to room temperature before profiling. The samples measured with APXPS were exposed to 1 mbar of H₂O exposure and annealing up to 500 °C. The exposure was done in a near ambient pressure cell within the XPS system. High resolution scans of the Ag 3d, Zr 3d, O 1s, Si 2p, C 1s and N 1s region were collected and the peaks were fit to identify the chemical species as it is being exposed and annealed. The deconvolution was performed using our Artificial Intelligence analysis package XPS Neo. This study shows that materials used in TRISO fuel (SiC and ZrN) have a strong reaction to water and high temperature and having a barrier layer of carbon to can effectively prevent oxidation of the materials. The Ag is effectively stopped by the ZrN layer. Adding a layer of ZrN may prevent exposure to workers during shutdowns.

Thin Films and Surface Modification

Room Naupaka Salon 4 - Session TF1-ThM

Thin Films - Plasma and Etching-related

Moderator: Sophie Senani-de Monredon, SAFRAN TECH

8:40am **TF1-ThM-3 Eco-Friendly Dry-Cleaning of Silicon Dioxide Deposition Chambers using a Cylinder-Type Remote Plasma Source with NF₃/N₂ Mixtures**, *Won Kyun Yeom, H. Gil*, Sungkyunkwan University, Republic of Korea; *G. Yeom*, Sungkyunkwan University (SKKU), Republic of Korea

Silicon dioxide (SiO₂) chamber cleaning is critical in semiconductor manufacturing, but traditional methods using perfluorocarbon gases like NF₃ raise environmental concerns due to their high global warming potential. This study presents a novel, eco-friendly approach utilizing a cylinder-type inductively coupled plasma remote plasma source (ICP RPS) with NF₃/N₂ gas mixtures for enhanced SiO₂ removal. The addition of a small amount of N₂ to NF₃ (1:9 ratio) was found to significantly improve cleaning efficiency and uniformity. Comprehensive plasma diagnostics, including quadrupole mass spectrometry (QMS), optical emission spectroscopy (OES), and Langmuir probe measurements, revealed that N₂ addition increases electron density and temperature, leading to enhanced generation and consumption of highly reactive fluorine radicals responsible for SiO₂ etching. This innovative process offers a promising pathway to reduce NF₃ consumption in SiO₂ chamber cleaning, mitigating environmental impact while maintaining high cleaning performance. The results of this study contribute valuable insights into the optimization of plasma-based cleaning processes for the semiconductor industry.

9:00am **TF1-ThM-4 Innovative Fluorite-Based High-Entropy Oxide: A Novel Electrocatalyst for All-Vanadium Redox Flow Batteries**, *Chen-Hao Wang*, National Taiwan University of Science and Technology, Taiwan **INVITED**

Vanadium Redox Flow Batteries (VRFBs) are emerging as a promising solution for large-scale energy storage, offering advantages such as high capacity, long lifespan, and scalability. This study introduces a novel approach using fluorite high-entropy oxides (HEO) nanoparticles as catalytic materials for VRFBs, synthesized through a surfactant-assisted hydrothermal method followed by calcination.

The research focuses on HEO compounds, which incorporate multiple metal cations into a single-phase crystal structure, resulting in unique properties. Among the samples tested, the HEO calcined at 750°C (HEO-750) demonstrated superior electrocatalytic performance for both V³⁺/V²⁺ and VO₂⁺/VO²⁺ redox couples.

Key findings include:

1. Excellent efficiency: VRFBs using HEO-750 achieved high coulombic efficiency (CE), voltage efficiency (VE), and energy efficiency (EE) at various current densities.
2. Durability: No significant degradation was observed after 500 charge-discharge cycles.
3. Enhanced performance: The improved results are attributed to the forming of a single-phase fluorite structure during calcination, facilitating vanadium redox reactions.
4. Beneficial properties: High surface area, good wettability, and abundant oxygen vacancies improve electrochemical performance and stability.

The study concludes that HEO catalysts show great potential as next-generation electrode materials for VRFBs, potentially leading to the development of high-performance, cost-effective energy storage systems for various applications.

9:40am **TF1-ThM-6 Reactive Ion Etching of InGaZnO using HFC-based Gas and Chamber Cleaning**, *Sang Jin Lee, J. Hong*, Sungkyunkwan University, Republic of Korea; *Y. Jeong, H. Cho, D. Jung, Y. Yeo*, Samsung Display, Republic of Korea; *D. Kim, G. Yeom*, Sungkyunkwan University, Republic of Korea

Indium gallium zinc oxide (IGZO) is one of the most important active layer semiconductor materials for next-generation semiconductor and display devices. In this study, IGZO was etched with various hydrofluorocarbon (HFC)-type gases composed of CH_xF_y and C₃H_xF_y in an inductively coupled plasma (ICP) etcher and, the etch characteristics and its cleaning characteristics have been investigated. The results showed that, among HFC gases used in the experiment, IGZO was etched faster with C₃H_xF_y compared to CH_xF_y and, especially, HFC gases with lower F in the gas chemistry

showed the better etch characteristics in addition to a low GWP. In addition, the etch by-products including dissociated HFC gases accumulated on the chamber wall could be in-situ cleaned using a H₂/Ar plasma. X-ray photoelectron spectroscopy (XPS), quadrupole mass spectrometer (QMS), and optical emission spectroscopy (OES) were used to understand the IGZO etch mechanism and chamber cleaning mechanism.

Thin Films and Surface Modification

Room Naupaka Salon 4 - Session TF2-ThM

Thin Films - Surface Modifications

Moderator: Hyo-Chang Lee, Korea Aerospace University

10:20am **TF2-ThM-8 Design at Nanoscale of Thermostable Hybrid Sol-Gel Bondlayer to Functionalize Aeronautical CFRP by Thermal Spray**, *Sophie Senani-de Monredon*, SAFRAN TECH, France; *L. Rozes*, Sorbonne Université, France; *G. Penvern*, SAFRAN TECH, Sorbonne Univ., France; *A. Joulia*, SAFRAN TECH, France; *S. Bonebeau*, SAFIR, France

Composite Fibers Reinforced Parts (CFRP) are widely used in aeronautics since more than 40 years to contribute to decrease the aircrafts environmental footprint. Indeed CO₂ and NO_x emissions have been considerably decreased by lightweighting correlated to significant fuel consumption reduction (15% for last LEAP aircraft engines). Nevertheless to go further and reach the new ambitious target of 20% reduction for the next aircraft engine, functionalization and metallization of CFRP is mandatory to extend them to more aggressive use cases than fuselage, by resistance against high temperature, erosion or icing. To reach this goal, thermal spray coatings are widely studied, even if it remains very complex to implement.

Metallization of CFRP, especially by cold spray is favored by numerous teams [1,2,3], with interesting results but not sufficient to fit performance required for aeronautics qualification. Our approach aims to design a thermostable sol-gel hybrid bondcoat. We will discuss how we succeeded to control of the chemical composition, the nanostructure of this bondlayer and the nature of the substrate/bondlayer/topcoat interfaces to influence the thermomechanical bondcoat's properties and thus the building and the thickness increase of the thermal sprayed topcoat layer linked to the adhesion of the stack. Understanding the relation between nanostructure of the hybrid sol-gel layer and their mechanical and thermal properties is essential to optimize the whole system. Finally, this will widely open the variety of materials (from metals to oxides) reachable to functionalize CFRP part and allow new use cases unthinkable up to now.

References

1- Cold spray of metal-polymer composite coatings onto carbon fiber-reinforced polymer (CFRP). V. Bortolussi, F. Borit, A. Chesnaud, M. Jeandin, M. Faessel, *et al.* International Thermal Spray Conference 2016 (ITSC 2016), DVS, May 2016, Shanghai, China. p.7 - hal-01337696

2-Metallization of polymers by cold spraying with low melting point powders

[<https://scholar.google.com/scholar?oi=bibs&cluster=18020247034159663012&btnI=1&hl=fr>]. H Che, AC Liberati, X Chu, M Chen, A Nobari, P. Vo, S. Yue, *Surface and Coatings Technology*, 2021, 418, p 127229

3- CO3 Project- F. Delloro *et al* (<https://www.projectco3.eu/fr/>)

10:40am **TF2-ThM-9 Sustainable Artificial Leather Production - Use of Alternative Textile Structures and Modification of Surfaces**, *Roxana Ley*, Institut fuer Textiltechnik der RWTH Aachen, Germany

Previous artificial leather manufacturing processes were mainly based on the use of polyvinyl chloride (PVC) or polyurethane (PU). These materials are applied in several layers to a carrier material and then bonded together. In most cases, the carrier material is a nonwoven. The resulting composite structures are often difficult to recycle due to the difficulty of separating the different layers of material and are therefore increasingly leading to a growing environmental problem. **USING TEXTILE KNOW-HOW TO MAKE THE ARTIFICIAL LEATHER MANUFACTURING PROCESS SUSTAINABLE** Integrating textile expertise into artificial leather production promotes sustainability. Innovative textile structures like weft knitted, warp knitted, and woven fabrics can reduce environmental impact and improve product quality. Spacer textiles, a special form of these structures, allow precise adjustment of distances between cover surfaces and targeted surface treatments. The advantages and disadvantages of these three textile

Thursday Morning, December 12, 2024

structures as base products for artificial leather are discussed below.

Weft *knitting*
Weft knitting involves creating loop structures by passing the working yarn through existing stitches. Spacer knits consist of two cover surfaces connected by pile threads, allowing flexible and quick customization during prototyping. However, weft knitted materials may have higher stretchability, potentially causing instability.

Warp *knitting*
Warp knitting produces closely intertwined loops using multiple needles. Spacer warp knitted fabrics, created on double raschel machines, feature two cover surfaces connected by pile threads. This method offers improved dimensional stability but involves a complex manufacturing process.

Weaving
Weaving creates fabric by crossing warp and weft threads. Double weave fabrics, formed by joining two basic fabrics with pile threads, offer high strength and stability. However, they may be less adaptable to complex shapes compared to knitted structures.

Surface *Treatment*
Surface treatments such as roughening, embossing, polishing, and coating can enhance the look and feel of artificial leather. These methods can replicate authentic leather textures or impart other properties like softness, grip, or shine. Employing surface treatments allows for the production of sustainable, high-quality faux leather products, promoting a circular economy and recycling by using mono-materials.

11:00am **TF2-ThM-10 Invited Paper, Sangmin An**, Jeonbuk National University, Republic of Korea **INVITED**

Author Index

Bold page numbers indicate presenter

— A —

Adams, D.: TF2-TuE-7, **5**
Addamane, S.: TF2-TuE-7, **5**
Almaguer-Flores, A.: TF1-TuE-4, **5**
An, S.: TF2-ThM-10, **12**
Arakawa, I.: TF-WeP-6, **8**

— B —

Benayoun, S.: TF1-MoE-3, **1**
Berman, D.: TF1-WeE-1, **9**
Bobaru, F.: TF2-TuE-8, **6**
Bonebeau, S.: TF2-ThM-8, **11**
Boyce, B.: TF2-TuE-7, **5**
Boyd, R.: TF2-WeE-7, **9**

— C —

Çağın, E.: TF-WeP-2, **7**
Carlotti, J.: TF2-TuE-9, **6**
Cavarroc, M.: TF2-WeE-9, **10**
Cho, H.: TF1-ThM-6, **11**
Ciobanu, C.: TF2-TuE-8, **6**
Crosby, T.: TF1-MoE-5, **1**
Cumpson, P.: TF2-MoE-10, **2**

— D —

Delfosse, J.: TF1-MoE-3, **1**
DelRio, F.: TF2-TuE-7, **5**
Devadasan, D.: TF2-MoE-10, **2**
Dietrich, P.: TF2-MoE-9, **2**
Dingreville, R.: TF2-TuE-7, **5**
Dorman, K.: TF2-TuE-7, **5**

— F —

Fernandez, I.: TF2-WeE-7, **9**

— G —

Gazzola, S.: TF2-MoE-10, **2**
Gil, H.: TF1-ThM-3, **11**
Glavin, N.: TF1-TuE-1, **5**

— H —

Helmersson, U.: TF2-WeE-7, **9**
Hendricks, N.: TF-WeP-2, **7**
Hirayama, A.: TF-WeP-6, **8**
Hong, J.: TF1-ThM-6, **11**
Hong, S.: TF1-WeE-4, **9**
Humiston, A.: TF-WeP-4, **7**
Hurd, M.: TF1-MoE-4, **1**

— J —

Jain, M.: TF2-TuE-7, **5**
Jang, H.: TF-TuP-6, **4**

Jeong, Y.: TF1-ThM-6, **11**

Jin, J.: TF-TuP-3, **3**

Jouliia, A.: TF2-ThM-8, **11**

Jung, D.: TF1-ThM-6, **11**

Jung, S.: TF1-TuE-3, **5**

— K —

Kaur, H.: TF1-WeE-3, **9**

Kim, D.: TF1-ThM-6, **11**; TF-WeP-3, **7**; TF-WeP-5, **7**

Kim, J.: TF1-TuE-3, **5**; TF-TuP-6, **4**

Kim, W.: TF2-TuE-10, **6**; TF-TuP-5, **3**

Koshiji, F.: TF-TuP-1, **3**

Kothari, R.: TF2-TuE-7, **5**

— L —

Lager, L.: TF1-MoE-3, **1**

Lee, H.: TF1-MoE-1, **1**; TF-WeP-1, **7**

Lee, J.: TF2-TuE-10, **6**; TF-TuP-5, **3**

Lee, S.: TF1-ThM-6, **11**; TF2-TuE-10, **6**; TF-WeP-3, **7**; TF-WeP-5, **7**

Lee, Y.: TF-WeP-3, **7**; TF-WeP-5, **7**

Leiws, A.: TF1-MoE-5, **1**

Ley, R.: TF2-ThM-9, **11**

Lundin, D.: TF2-WeE-7, **9**

— M —

Maillard, M.: TF2-TuE-9, **6**

Marichy, C.: TF2-TuE-9, **6**

Marquez, D.: TF2-WeE-9, **10**

Martinez, C.: TF2-TuE-7, **5**

Massey, J.: TF1-MoE-4, **1**

Messerle, V.: TF-TuP-2, **3**

Michau, D.: TF2-WeE-9, **10**

Muhammad, J.: TF1-MoE-5, **1**

Muratore, C.: TF1-TuE-1, **5**

Muratore, M.: TF1-TuE-1, **5**

Murphy, S.: TF1-WeE-3, **9**

— N —

Nagakura, H.: TF2-WeE-7, **9**

Neyrat, J.: TF2-WeE-9, **10**

Nunney, T.: TF2-MoE-10, **2**

— O —

Oh, I.: TF-TuP-4, **3**

Oh, J.: TF2-TuE-10, **6**; TF-TuP-5, **3**

— P —

Paige, M.: TF1-WeE-3, **9**

Park, H.: TF-WeP-1, **7**

Penvern, G.: TF2-ThM-8, **11**

Perez-Bucio, V.: TF1-TuE-4, **5**

Poulon-Quintin, A.: TF2-WeE-9, **10**

— R —

Reyes-Carmona, L.: TF1-TuE-4, **5**

Robertson, B.: TF1-TuE-1, **5**

Rodil, S.: TF1-TuE-4, **5**

Rodriguez, M.: TF2-TuE-7, **5**

Rozes, L.: TF2-ThM-8, **11**

— S —

Saitou, Y.: TF-TuP-1, **3**

Salles, V.: TF2-TuE-9, **6**

Senani-de Monredon, S.: TF2-ThM-8, **11**

Senani-De Monredon, S.: TF1-MoE-3, **1**

Sepulveda-Robles, O.: TF1-TuE-4, **5**

Shilt, T.: TF2-TuE-7, **5**

Shimizu, T.: TF2-WeE-7, **9**

Sim, J.: TF-WeP-1, **7**

Sobczak, C.: TF2-TuE-7, **5**

Souvignet, T.: TF2-TuE-9, **6**

Stan, G.: TF2-TuE-8, **6**

Sumat, S.: TF1-WeE-3, **9**

Sung, J.: TF-TuP-3, **3**

Syed, M.: TF1-MoE-4, **1**; TF1-MoE-5, **1**

syeda, M.: TF1-MoE-4, **1**

Syeda, M.: TF1-MoE-5, **1**

— T —

Tae, H.: TF-TuP-6, **4**

Terry, J.: TF2-WeE-10, **10**; TF-WeP-4, **7**

Tokuta, Y.: TF2-WeE-7, **9**

Toury, B.: TF1-MoE-3, **1**

Toyoshima, R.: TF2-MoE-7, **1**

— U —

Uchida, T.: TF-TuP-1, **3**

Ustimenko, A.: TF-TuP-2, **3**

— W —

Wang, C.: TF1-ThM-4, **11**

Wang, D.: TF1-WeE-5, **9**

Weatherup, R.: TF2-MoE-10, **2**

— Y —

Yamakawa, K.: TF-WeP-6, **8**

Yasuda, Y.: TF-TuP-1, **3**

Yeo, Y.: TF1-ThM-6, **11**

Yeom, G.: TF1-ThM-3, **11**; TF1-ThM-6, **11**

Yeom, W.: TF1-ThM-3, **11**